Test Equipment Solutions Datasheet

Test Equipment Solutions Ltd specialise in the second user sale, rental and distribution of quality test & measurement (T&M) equipment. We stock all major equipment types such as spectrum analyzers, signal generators, oscilloscopes, power meters, logic analysers etc from all the major suppliers such as Agilent, Tektronix, Anritsu and Rohde & Schwarz.

We are focused at the professional end of the marketplace, primarily working with customers for whom high performance, quality and service are key, whilst realising the cost savings that second user equipment offers. As such, we fully test & refurbish equipment in our in-house, traceable Lab. Items are supplied with manuals, accessories and typically a full no-quibble 2 year warranty. Our staff have extensive backgrounds in T&M, totalling over 150 years of combined experience, which enables us to deliver industry-leading service and support. We endeavour to be customer focused in every way right down to the detail, such as offering free delivery on sales, covering the cost of warranty returns BOTH ways (plus supplying a loan unit, if available) and supplying a free business tool with every order.

As well as the headline benefit of cost saving, second user offers shorter lead times, higher reliability and multivendor solutions. Rental, of course, is ideal for shorter term needs and offers fast delivery, flexibility, try-before-you-buy, zero capital expenditure, lower risk and off balance sheet accounting. Both second user and rental improve the key business measure of Return On Capital Employed.

We are based near Heathrow Airport in the UK from where we supply test equipment worldwide. Our facility incorporates Sales, Support, Admin, Logistics and our own in-house Lab.

All products supplied by Test Equipment Solutions include:

- No-quibble parts & labour warranty (we provide transport for UK mainland addresses).
- Free loan equipment during warranty repair, if available.
- Full electrical, mechanical and safety refurbishment in our in-house Lab.
- Certificate of Conformance (calibration available on request).
- Manuals and accessories required for normal operation.
- Free insured delivery to your UK mainland address (sales).
- Support from our team of seasoned Test & Measurement engineers.
- ISO9001 quality assurance.

Test equipment Solutions Ltd Unit 8 Elder Way Waterside Drive Langley Berkshire SL3 6EP

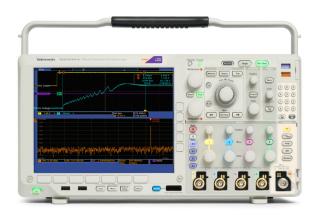
T: +44 (0)1753 596000 F: +44 (0)1753 596001

Email: info@TestEquipmentHQ.com Web: www.TestEquipmentHQ.com



Mixed Domain Oscilloscopes

MDO4000 Series Data Sheet



Features & Benefits

Key Performance Specifications

- 4 Analog Channels
 - 500 MHz or 1 GHz Bandwidth Models
- 16 Digital Channels
 - MagniVu[™] High-speed Acquisition provides 60.6 ps Fine Timing Resolution
- 1 RF Channel
 - 50 kHz 3 GHz or 50 kHz 6 GHz Frequency Range Models
 - Ultra-wide Capture Bandwidth ≥1 GHz
- Standard Passive Voltage Probes 3.9 pF Capacitive Loading and 500 MHz or 1 GHz Analog Bandwidth

Mixed Domain Analysis

- Time-correlated Analog, Digital, and RF Signal Acquisitions in a Single Instrument
- Wave Inspector® Controls provide Easy Navigation of Time-correlated Data from both the Time and Frequency Domains
- Amplitude, Frequency, and Phase vs. Time Waveforms derived from RF Input
- Selectable Spectrum Time to Discover and Analyze how RF Spectrum Changes over Time – Even on a Stopped Acquisition

Spectral Analysis

- Dedicated Front-panel Controls for Commonly Performed Tasks
- Automated Peak Markers Identify Frequency and Amplitude of Spectrum Peaks
- Manual Markers enable Non-peak Measurements
- Trace Types Include: Normal, Average, Max Hold, and Min Hold
- Detection Types Include: +Peak, –Peak, Average, and Sample
- Spectrogram Display enables Easy Observation and Insight into Slowly Changing RF Phenomena
- Automated Measurements Include: Channel Power, Adjacent Channel Power Ratio (ACPR), and Occupied Bandwidth (OBW)
- Trigger on RF Power Level
- Triggered or Free Run Spectral Analysis

Ease of Use Features

- 10.4 in. (264 mm) Bright XGA Color Display
- Small Footprint and Lightweight Only 5.8 in. (147 mm) Deep and 11 lb. (5 kg)

Connectivity

- Two USB 2.0 Host Ports on the Front Panel and Two on the Rear Panel for Quick and Easy Data Storage, Printing, and Connecting a USB Keyboard
 - USB 2.0 Device Port on Rear Panel for Easy Connection to a PC or Direct Printing to a PictBridge®-compatible Printer
 - Integrated 10/100/1000BASE-T Ethernet Port for Network Connection and Video Out Port to Export the Oscilloscope Display to a Monitor or Projector

Optional Serial Triggering and Analysis

 Serial Protocol Trigger, Decode, and Search for I²C, SPI, USB, Ethernet, CAN, LIN, FlexRay, RS-232/422/485/UART, MIL-STD-1553, and I²S/LJ/RJ/TDM

Optional Application Support

- Advanced RF Triggering
- Power Analysis
- Limit and Mask Testing
- HDTV and Custom Video Analysis

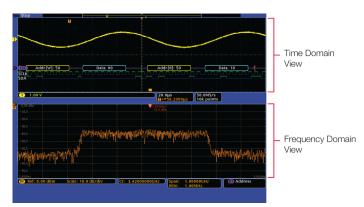


Introducing the Mixed Domain Oscilloscope

Introducing the world's first and only oscilloscope with a built-in spectrum analyzer. For the first time ever, you can capture time-correlated analog, digital, and RF signals for a complete system view of your device. See both the time and frequency domain in a single glance. View the RF spectrum at any point in time to see how it changes over time or with device state. Solve the most complicated design issues, quickly and efficiently, with an oscilloscope as integrated as your design.

Based on the industry-standard MSO4000B Oscilloscope Series, you can now use your tool of choice, the oscilloscope, to look at the frequency domain rather than having to find and re-learn a spectrum analyzer. However, the power of the MDO goes well beyond simply observing the frequency domain as you would on a spectrum analyzer. The real power is in its ability to correlate events in the frequency domain with the time domain phenomena that caused them.

When both the RF channel and any analog or digital channels are on, the oscilloscope display is split into two views. The upper half of the display is a traditional oscilloscope view of the Time Domain. The lower half of the display is a Frequency Domain view of the RF input. Note that the Frequency Domain view is not simply an FFT of the analog or digital channels in the instrument, but is the spectrum acquired from the RF input. The spectrum shown in the Frequency Domain view is taken from the period of time indicated by the short orange bar in the time domain view – known as the Spectrum Time. With the MDO4000 Series, Spectrum Time can be moved through the acquisition to investigate how the RF spectrum changes over time. And this can be done while the oscilloscope is live and running or on a stopped acquisition.



The upper half of the MDO4000 Series display shows the Time Domain view of the analog and digital channels, while the lower half shows the Frequency Domain view of the RF channel. The orange bar – Spectrum Time – shows the period of time used to calculate the RF spectrum.

Figures 1 through 4 show a simple everyday application – tuning of a VCO/PLL. This application illustrates the powerful connection between the time domain and the frequency domain that the MDO4000 Series provides. With its wide capture bandwidth and ability to move Spectrum Time throughout the acquisition, this single capture includes the same spectral content as approximately 4,500 unique test setups and acquisitions on a traditional spectrum analyzer. For the first time ever, correlating events, observing interactions, or measuring timing latencies between the two domains is exceptionally easy, giving you quick insight to your design's operation.

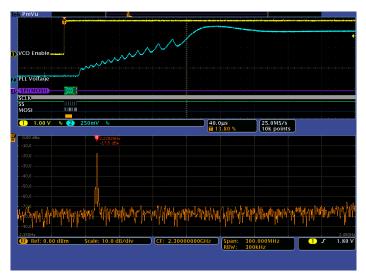


Figure 1 – Time and Frequency Domain view showing the turn-on of a VCO/PLL. Channel 1 (yellow) is probing a control signal that enables the VCO. Channel 2 (cyan) is probing the PLL voltage. The SPI bus which is programming the VCO/PLL with the desired frequency is probed with three digital channels and automatically decoded. Notice Spectrum Time is placed after the VCO was enabled and coincident with the command on the SPI bus telling the VCO/PLL the desired frequency.

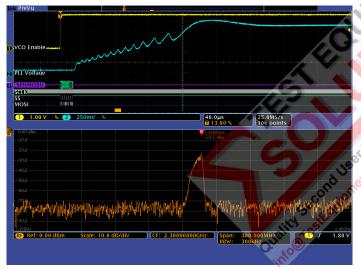


Figure 2 – Spectrum Time is moved about 60 µs to the right. At this point, the spectrum shows that the VCO/PLL is in the process of tuning to the correct frequency (2.400 GHz). It has made it up to 2.3168 GHz.

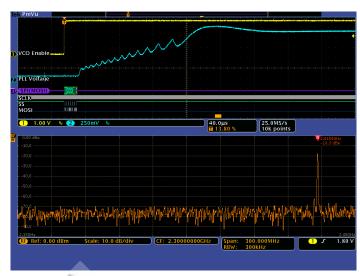


Figure 3 – Spectrum Time is moved another 120 µs to the right. At this point the spectrum shows that the VCO/PLL has actually overshot the correct frequency and gone all the way to 2.4164 GHz.

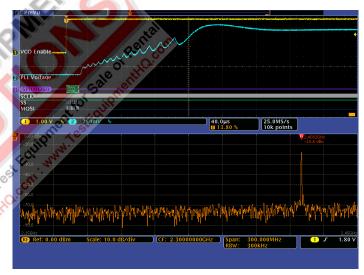
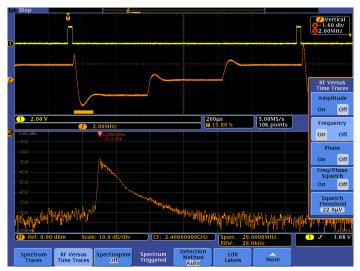


Figure 4 – The VCO/PLL eventually settles on the correct 2.400 GHz frequency about 340 µs after the VCO was enabled.



The orange waveform in the Time Domain view is the frequency vs. time trace derived from the RF input signal. Notice that Spectrum Time is positioned during a transition from the highest frequency to the lowest frequency, so the energy is spread across a number of frequencies. With the frequency vs. time trace, you can easily see the different frequency hops, simplifying characterization of how the device switches between frequencies.

Visualizing Changes in Your RF Signal

The time domain graticule on the MDO4000 Series display provides support for three RF time domain traces that are derived from the underlying I and Q data of the RF input including:

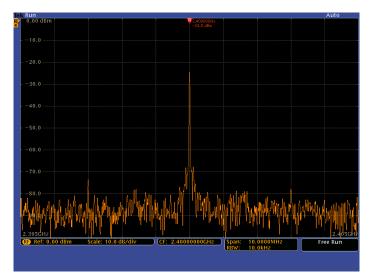
- Amplitude The instantaneous amplitude of the RF input vs. time
- Frequency The instantaneous frequency of the RF input, relative to the center frequency vs. time
- Phase The instantaneous phase of the RF input, relative to the center frequency vs. time

Each of these traces may be turned on and off independently, and all three may be displayed simultaneously. RF time domain traces make it easy to understand what's happening with a time-varying RF signal.

Advanced Triggering

In order to deal with the time-varying nature of modern RF applications, the MDO4000 Series provides a triggered acquisition system that is fully integrated with the RF, analog, and digital channels. This means that a single trigger event coordinates acquisition across all channels, allowing you to capture a spectrum at the precise point in time where an interesting time domain event is occurring. A comprehensive set of time domain triggers are available, including Edge, Sequence, Pulse Width, Timeout, Runt, Logic, Setup/Hold Violation, Rise/Fall Time, Video, and a variety of parallel and serial bus packet triggers. In addition, you can trigger on the power level of the RF input. For example, you can trigger on your RF transmitter turning on.

The optional MDO4TRIG application module provides advanced RF triggering. This module enables the RF input power level to be used as a source for Sequence, Pulse Width, Timeout, Runt, and Logic trigger types. For example, you can trigger on a RF pulse of a specific length or use the RF channel as an input to a logic trigger, enabling the oscilloscope to trigger only when the RF is on white other signals are active.



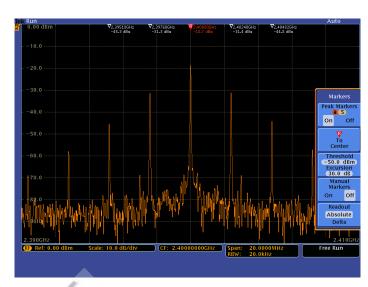
MDO4000 Frequency Domain display.



Key spectral parameters are adjusted quickly with the dedicated front-panel menus and keypad.

Fast and Accurate Spectral Analysis

When using the RF input by itself, the MDO4000 Series display becomes a full-screen Frequency Domain view.



Automated peak markers identify critical information at a glance. As shown here, the five highest amplitude peaks that meet the threshold and excursion criteria are automatically marked.

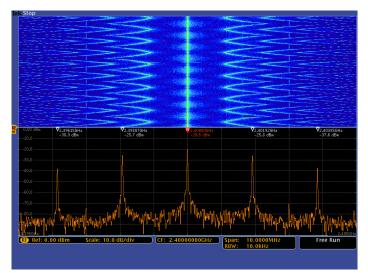
Key spectral parameters such as Center Frequency, Span, Reference Level, and Resolution Bandwidth are all adjusted quickly and easily using the dedicated front-panel menus and keypad.

Intelligent, Efficient Markers

In a traditional spectrum analyzer, it can be a very tedious task to turn on and place enough markers to identify all your peaks of interest. The MDO4000 Series makes this process far more efficient by automatically placing markers on peaks that indicate both the frequency and the amplitude of each peak. The criteria used to determine what a peak is can be adjusted by the user.

The highest amplitude peak is referred to as the reference marker and is shown in red. Marker readouts can be switched between Absolute and Delta readouts. When Delta is selected, marker readouts show each peak's delta frequency and delta amplitude from the reference marker.

Two manual markers are also available for measuring non-peak portions of the spectrum. When enabled, the reference marker is attached to one of the manual markers, enabling delta measurements from anywhere in the spectrum. In addition to frequency and amplitude, manual marker readouts also include noise density and phase noise readouts depending on whether Absolute or Delta readouts are selected. A "Reference Marker to Center" function instantly moves the frequency indicated by the reference marker to center frequency.



Spectrogram display illustrates slowly moving RF phenomena. As shown here, a signal that has multiple peaks is being monitored. As the peaks change in both frequency and amplitude over time, the changes are easily seen in the Spectrogram display.

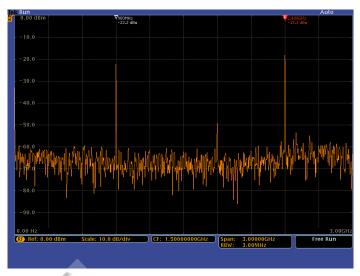
Spectrogram

The MDO4000 Series includes a spectrogram display which is ideal for monitoring slowly changing RF phenomena. The x-axis represents frequency, just like a typical spectrum display. However, the y-axis represents time, and color is used to indicate amplitude.

Spectrogram slices are generated by taking each spectrum and "flipping it up on its edge" so that it's one pixel row tall, and then assigning colors to each pixel based on the amplitude at that frequency. Cold colors (blue, green) are low amplitude and hotter colors (yellow, red) are higher amplitude. Each new acquisition adds another slice at the bottom of the spectrogram and the history moves up one row. When acquisitions are stopped, you can scroll back through the spectrogram to look at any individual spectrum slice.

Triggered vs. Free Run Operation

When both the time and frequency domains are displayed, the spectrum shown is always triggered by the system trigger event and is time correlated with the active time-domain traces. However, when only the frequency domain is displayed, the RF input can be set to Free Run. This is useful when the frequency domain data is continuous and unrelated to events occurring in the time domain.



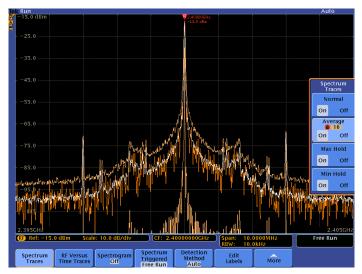
Spectral display of a bursted communication both into a device through Zigbee at 900 MHz and out of the device through Bluetooth at 2.4 GHz, captured with a single acquisition.

Ultra-wide Capture Bandwidth

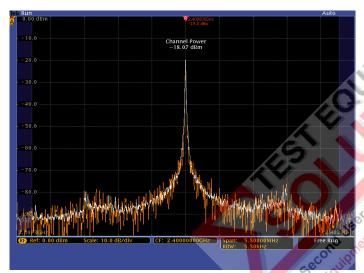
Today's wireless communications vary significantly with time, using sophisticated digital modulation schemes and, often, transmission techniques that involve bursting the output. These modulation schemes can have very wide bandwidth as well. Traditional swept or stepped spectrum analyzers are ill equipped to view these types of signals as they are only able to look at a small portion of the spectrum at any one time.

The amount of spectrum acquired in one acquisition is called the capture bandwidth. Traditional spectrum analyzers sweep or step the capture bandwidth through the desired span to build the requested image. As a result, while the spectrum analyzer is acquiring one portion of the spectrum, the event you care about may be happening in another portion of the spectrum. Most spectrum analyzers on the market today have 10 MHz capture bandwidths, sometimes with expensive options to extend that to 20, 40, or even 140 MHz in some cases.

In order to address the bandwidth requirements of modern RF, the MDO4000 Series provides ≥1 GHz of capture bandwidth. At span settings of 1 GHz and below, there is no requirement to sweep the display. The spectrum is generated from a single acquisition, thus guaranteeing you'll see the events you're looking for in the frequency domain.



Normal, Average, Max Hold, and Min Hold spectrum traces.



Automated Channel Power measurement.

Spectrum Traces

The MDO4000 Series offers four different traces or views of the RF input including Normal, Average, Max Hold, and Min Hold. You can set the



The optional TPA-N-VPI adapter enables any active, 50 Ω TekVPI probe to be connected

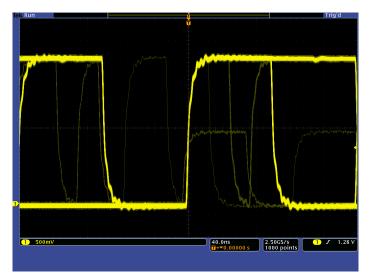
detection method used for each trace type independently or you can leave the oscilloscope in the default Auto mode that sets the detection type optimally for the current configuration. Detection types include +Peak, -Peak, Average, and Sample.

RF Measurements

The MDO4000 Series includes three automated RF measurements -Channel Power, Adjacent Channel Power Ratio, and Occupied Bandwidth. When one of these RF measurements is activated, the oscilloscope automatically turns on the Average spectrum trace and sets the detection method to Average for optimal measurement results.

RF Probing

Signal input methods on spectrum analyzers are typically limited to cabled connections or antennas. But with the optional TPA-N-VPI adapter, any active, 50 Ω TekVPI probe can be used with the RF input on the MDO4000 Series. This enables additional flexibility when hunting for noise sources and enables easier spectral analysis by using true signal browsing on an RF input.



Discover – Fast waveform capture rate - over 50,000 wfm/s - maximizes the probability of capturing elusive glitches and other infrequent events.

Built-on the Award Winning MSO4000B Series of Mixed Signal Oscilloscopes

The MDO4000 Series provides you with the same comprehensive set of features available in the MSO4000B Mixed Signal Oscilloscope Series. This robust set of tools will help you speed through every stage of debugging your design – from quickly discovering an anomaly and capturing it, to searching your waveform record for the event and analyzing its characteristics and your device's behavior.

Discover

To debug a design problem, first you must know it exists. Every design engineer spends time looking for problems in their design, a time-consuming and frustrating task without the right debug tools.

The MDO4000 Series offers the industry's most complete visualization of signals, providing fast insight into the real operation of your device. A fast waveform capture rate – greater than 50,000 waveforms per second – enables you to see glitches and other infrequent transients within seconds, revealing the true nature of device faults. A digital phosphor display with intensity grading shows the history of a signal's activity by intensifying areas of the signal that occur more frequently, providing a visual display of just how often anomalies occur.



Capture – Triggering on a specific transmit data packet going across a SPI bus. A complete set of triggers, including triggers for specific serial packet content, ensures you quickly capture your event of interest.

Capture

Discovering a device fault is only the first step. Next, you must capture the event of interest to identify root cause.

Accurately capturing any signal of interest begins with proper probing. The MDO4000 Series includes four low-capacitance probes for accurate signal capture. These industry-first high-impedance passive voltage probes have less than 4 pF of capacitive loading to minimize the affect of the probe on your circuit's operation, offering the performance of an active probe with the flexibility of a passive probe.

The MDO4000 Series provides a complete set of triggers – including Runt, Timeout, Logic, Pulse Width/Glitch, Setup/Hold Violation, Serial Packet, and Parallel Data – to help quickly find your event. With up to a 20M point record length, you can capture many events of interest, even thousands of serial packets, in a single acquisition for further analysis while maintaining high resolution to zoom in on fine signal details.

From triggering on specific packet content to automatic decode in multiple data formats, the MDO4000 Series provides integrated support for the industry's broadest range of serial buses – I²C, SPI, USB, Ethernet, CAN, LIN, FlexRay, RS-232/422/485/UART, MIL-STD-1553, and I²S/LJ/RJ/TDM. The ability to decode up to four serial and/or parallel buses simultaneously means you gain insight into system-level problems quickly.

To further help troubleshoot system-level interactions in complex embedded systems, the MDO4000 Series offers 16 digital channels. The MagniVu™ high-speed acquisition on these channels enables you to acquire fine signal detail (up to 60.6 ps resolution) around the trigger point for precision measurements. MagniVu is essential for making accurate timing measurements for setup and hold, clock delay, signal skew, and glitch characterization.



Search – RS-232 decode showing results from a Wave Inspector® search for data value "n". Wave Inspector controls provide unprecedented efficiency in viewing and navigating waveform data.

Search

Finding your event of interest in a long waveform record can be time consuming without the right search tools. With today's record lengths pushing beyond a million data points, locating your event can mean scrolling through thousands of screens of signal activity.

The MDO4000 Series offers the industry's most comprehensive search and waveform navigation with its innovative Wave Inspector® controls. These controls speed panning and zooming through your record. With a unique force-feedback system, you can move from one end of your record to the other in just seconds. User marks allow you to mark any location that you may want to reference later for further investigation. Or, automatically search your record for criteria you define. Wave Inspector will instantly search your entire record, including analog, digital, and serial bus data. Along the way it will automatically mark every occurrence of your defined event so you can quickly move between each occurrence.



Analyze – Waveform histogram of a falling edge showing the distribution of edge position (jitter) over time. Included are numeric measurements made on the waveform histogram data. A comprehensive set of integrated analysis tools speeds verification of your design's performance.

Analyze

Verifying that your prototype's performance matches simulations and meets the project's design goals requires analyzing its behavior. Tasks can range from simple checks of rise times and pulse widths to sophisticated power loss analysis and investigation of noise sources.

The MDO4000 Series offers a comprehensive set of integrated analysis tools including waveform- and screen-based cursors, 44 automated measurements, and advanced waveform math including arbitrary equation editing, waveform histograms, FFT analysis, and trend plots for visually determining how a measurement is changing over time. Specialized application support for serial bus analysis, power supply design, limit and mask testing, and video design and development is also available.

For extended analysis, National Instrument's LabVIEW SignalExpress™ Tektronix Edition provides over 200 built-in functions including time and

frequency domain analysis, data logging, and customizable reports.

Specifications

Characteristic	MDO4054-3	MDO4104-3	MDO4054-6	MDO4104-6
Analog Channels			4	
Bandwidth	500 MHz	1 GHz	500 MHz	1 GHz
Sample Rate (1-2 ch)	2.5 GS/s	5 GS/s	2.5 GS/s	5 GS/s
Sample Rate (3-4 ch)		2.5	GS/s	
Digital Channels			16	
RF Channels			1	
Frequency Range	50 kHz	: - 3 GHz	50 kHz	- 6 GHz
Real-time Capture Bandwidth		≥1	GHz	
Span		1 kHz - 3/6 GHz i	in a 1-2-5 sequence	
Resolution Bandwidth		20 Hz - 10 MHz in	a 1-2-3-5 sequence	
Reference Level		-140 dBm to +30 d	Bm in steps of 5 dBm	
Vertical Scale		1 dB/div to 20 dB/di	v in a 1-2-5 sequence	
Vertical Position		-10 divs	to +10 divs	
Vertical Units		dBm, dBmV, dBµV,	dBμW, dBmA, dBμA	
Displayed Average Noise		50 kHz - 5 MHz: < -130 dB	m/Hz (< -134 dBm/Hz typical)	
Level (DANL)			m/Hz (< -152 dBm/Hz typical)	
Caudana Danasaa		3 GHz - 6 GHz: < -140 dBi	m/Hz (< -143 dBm/Hz typical)	
Spurious Response		A FE ID I	-60 dBc typical)	
2nd and 3rd Harmonic Distortion (>30 MHz)			oel on	
2nd Order Intermodulation Distortion			-60 dBc typical)	
3rd Order Intermodulation Distortion			-63 dBc typical)	
Other A/D Spurs		< –55 dBc (<	–60 dBc typical)	
Image and IF Rejection	20	< <u>-50</u> dBc (<	–55 dBc typical)	
Residual Response	250		8 dBm	
Crosstalk to RF Channel from Scope Channels			es: < -68 dB from ref level encies: < -48 dB from ref level	
Phase Noise at 2 GHz CW	L C	100 kHz; < -95 dBc/H 1 MHz; < -113 dBc/Hz	z, < –95 dBc/Hz (typical) z, < –98 dBc/Hz (typical) z, < –118 dBc/Hz (typical)	
Level Measurement Uncertainty (Input level +10 dBm to –50 dBm)			dB (< ±0.5 dB typical) range: < ±1.5 dB	
Residual FM			to-peak in 100 ms	
Maximum Operating Input Level	- Jall	= 100 Hz peak-t	to pour in 100 ms	
Average Continuous Power	O. K.	, 20 4E	2m (1 \M\)	
DC Maximum Before	il.		8m (1 W) V DC	
DC Maximum Before Damage		±40	۷ ا	
Maximum Power Before Damage (CW)		+33 dE	Bm (2 W)	
Maximum Power Before		+45 dB	m (32 W)	
Damage (Pulse)			le, and reference level of ≥ +10 dBr	m)
Power Level Trigger				
Frequency Range	1 MHz	- 3 GHz	1 MHz	- 6 GHz
Amplitude Range		+30 dBm	to -40 dBm	
Limits			GHz: -35 dB from ref level -15 dB from ref level	
Minimum Pulse Duration			num settling Off Time of 10 µs	
RF to Analog Channel Skew		•	5 ns	

Characteristic	MDO4054-3	MDO4104-3	MDO4054-6	MDO4104-6
Frequency Domain Trace Types		Normal, Average,	Max Hold, Min Hold	
Time Domain Trace Types		Amplitude vs. Time, Frequer	ncy vs. Time, Phase vs. Time	
Detection Methods		+Peak, -Peak,	Average, Sample	
Automatic Markers		1-11 peaks identified based on user-ac	ljustable threshold and excursion va	alues
Manual Markers		Two manual markers indicating frequency	amplitude, noise density, and phas	se noise
Marker Readouts	•	Absolute	e or Delta	

RF Acquisition Length

Span	Maximum RF Acquisition Time	
>2 GHz	2.5 ms	
>1 GHz - 2 GHz	5 ms	
>800 MHz - 1 GHz	10 ms	
>500 MHz - 800 MHz	12.5 ms	
>400 MHz - 500 MHz	20 ms	
>250 MHz - 400 MHz	25 ms	
>200 MHz - 250 MHz	40 ms	
>160 MHz - 200 MHz	50 ms	
>125 MHz - 160 MHz	62.5 ms	
<125 MHz	79 ms	
	<u>-</u>	

FFT Windows

FFT Window	Factor
Kaiser	2.23
Rectangular	0.89
Hamming	1.30
Hanning	1.44
Blackman-Harris	1.90
Flat-Top	3.77

Vertical System Analog Channels

Characteristic	MDO4054-X	MDO4104-X
Input Channels	4	
Analog Bandwidth (–3 dB) 5 mV/div - 1 V/div	500 MHz	1 GHz
Calculated Rise Time 5 mV/div (typical)	700 ps	350 ps
Hardware Bandwidth Limits	20 MHz or	250 MHz
Input Coupling	AC,	DC
Input Impedance	1 MΩ ±1%,	50 Ω ±1%
Input Sensitivity, 1 MΩ	1 mV/div to	o 10 V/div
Input Sensitivity, 50 Ω	1 mV/div to 1 V/div	
Vertical Resolution	8 bits (11 bits	with Hi Res)
Max Input Voltage, 1 MΩ	300 V _{RMS} CAT II wit	th peaks ≤ ±425 V
Max Input Voltage, 50 Ω	5 V _{RMS} with pe	eaks < ±20 V
DC Gain Accuracy	±1.5%, derated at 0.1	10%/°C above 30 °C
Channel-to-Channel Isolation	≥100:1 at ≤100 MHz al up to the rated bandwid having equal vo	th for any two channels

Offset Range

Range	1 ΜΩ	50 Ω
1 mV/div to 50 mV/div	±1 V	±1 V
50.5 mV/div to 99.5 mV/div	±0.5 V	±0.5 V
100 mV/div to 500 mV/div	±10 V	±10 V
505 mV/div to 995 mV/div	±5 V	±5 V
1 V/div to 5 V/div	±100 V	±5 V
5.05 V/div to 10 V/div	±50 V	NA 📉

Vertical System Digital Channels

Characteristic	All MDO4000 Models
Input Channels	16 Digital (D15 - D0)
Thresholds	Per-channel Thresholds
Threshold Selections	TTL, CMOS, ECL, PECL, User Defined
User-defined Threshold Range	±40 V
Maximum Input Voltage	±42 V _{peak}
Threshold Accuracy	±(100 mV + 3% of threshold setting)
Input Dynamic Range	30 V _{p-p} ≤200 MHz 10 V _{p-p} >200 MHz
Minimum Voltage Swing	400 mV
Input Impedance	100 kΩ
Probe Loading	3 pF
Vertical Resolution	1 bit

Horizontal System Analog Channels

Characteristic	MDO4054-X	MDO4104-X
Maximum Record Length (All channels)	20M p	points
Maximum Duration at Highest Sample Rate (All/Half channels)	8/8 ms	8/4 ms
Time Base Range	1 ns to 1,000 s	400 ps to 1,000 s
Time Base Delay Time Range	–10 division	s to 5000 s
Channel-to-Channel Deskew Range	±125	5 ns
Time Base Accuracy	±5 ppm over any	y ≥1 ms interval

Horizontal System Digital Channels

	•	•
	Characteristic	All MDO4000 Models
	Maximum Sample Rate (Main)	500 MS/s (2 ns resolution)
	Maximum Record Length (Main)	20M points
	Maximum Samp <mark>le Rate</mark> (MagniVu)	16.5 GS/s (60.6 ps resolution)
?	Maximum Record Length (MagniVu)	10k points centered around the trigger
•	Minimum Detectable Pulse Width (Typical)	1 ns
	Channel-to-Channel Skew (Typical)	200 ps
	Maximum Input Toggle Rate	500 MHz
0	Maximum Input Toggle Rate	Maximum frequency sine wave that can accurately be reproduced as a logic square wave. Requires the use of a short ground extender on each channel.
	con	This is the maximum frequency at the minimum swing amplitude. Higher toggle rates can be achieved with higher amplitudes.

Trigger System

Characteristic	Description
Main Trigger Modes	Auto, Normal, and Single
Trigger Coupling	DC, AC, HF reject (attenuates >50 kHz), LF reject (attenuates <50 kHz), noise reject (reduces sensitivity)
Trigger Holdoff Range	20 ns to 8 s

Trigger Sensitivity

Characteristic	Description
Internal DC Coupled	
1 MΩ Path (All models)	For 1 mV/div to 4.98 mV/div; 0.75 div from DC to 50 MHz, increasing to 1.3 div at rated bandwidth
50 Ω Path (MDO4054-X)	For ≥5 mV/div; 0.4 div from DC to 50 MHz, increasing to 1 div at rated bandwidth
50 Ω Path (MDO4104-X)	0.4 div from DC to 50 MHz, increasing to 1 div at rated bandwidth

Trigger Level Range

Characteristic	Description
Any Channel	±8 divisions from center of screen
Line	Fixed at about 50% of line voltage

Trigger Frequency Readout

Provides 6-digit frequency readout of triggerable events.

Trigger Modes

Mode	Description	
Edge	Positive or negative slope on any channel. Coupling includes DC, AC, HF reject, LF reject, and noise reject	
Sequence (B-trigger)	Trigger Delay by Time – 4 ns to 8 s. Or Trigger Delay by Events – 1 to 4,000,000 events	
Pulse Width	Trigger on width of positive or negative pulses that are >, <, =, or ≠ a specified period of time (4 ns to 8 s)	
Timeout	Trigger when no pulse is detected within a specified time (4 ns to 8 s)	
Runt	Trigger on a pulse that crosses one threshold but fails to cross a second threshold before crossing the first again	
Logic	Trigger when any logical pattern of channels goes false or stays true for specified period of time (4 ns to 8 s). Any input can be used as a clock to look for the pattern on a clock edge. Pattern (AND, OR, NAND, NOR) specified for all analog and digital input channels defined as High, Low, or Don't Care	
Setup and Hold	Trigger on violations of both setup time and hold time between clock and data present on any of the input channels	
Rise/Fall Time	Trigger on pulse edge rates that are faster or slower than specified. Slope may be positive, negative, or either	
Video	Trigger on all lines, odd, even, or all fields on NTSC, PAL, and SECAM video signals	
Extended Video (Optional)	Trigger on 480p/60, <mark>576p/50</mark> , 720p/30, 720p/50, <mark>720</mark> p/60, 875i/60, 1080i/50, 1080i/60, 1080p/24, 1080p/24sF, 1080p/25, 1080p/30, 1080p/50, 1080p/60, and custom bi-level and tri-level sync video standards	
I ² C (Optional)	Trigger on Start, Repeated Start, Stop, Missing ACK, Address (7 or 10 bit), Data, or Address and Data on I ² C buses up to 10 Mb/s	
SPI (Optional)	Trigger on SS active, MOSI, MISO, or MOSI and MISO on SPI buses up to 50 Mb/s	

Mode Description USB (Optional) Low-speed: Trigger on Sync, Reset, Suspend, Resume, End of Packet, Token (Address) Packet, Data Packet, Handshake Packet, Special Token packet trigger – Any token type, SOF, OUT, IN, SETUP; Address can be specified for Any Token, OUT, IN, and SETUP token types. Address can be further specified to trigger on ≤, <, =, >, ≥, ≠ a particular value, or inside or outside of a range. Frame number can be specified for SOF token using binary, hex, unsigned decimal and don't care digits. Data packet trigger – Any data type, DATA0, DATA1; Data can be further specified to trigger on ≤, <, =, >, ≥, ≠ a particular data value, or inside or outside of a range. Handshake packet trigger - Any handshake type, ACK, NAK, STALL. Special packet trigger - Any special type, Reserved. Error trigger - PID Check, CRC5 or CRC16, Bit Stuffing. Full-speed: Trigger on Sync, Reset, Suspend, Resume, End of Packet, Token (Address) Packet, Data Packet, Handshake Packet, Special Packet, Error. Token packet trigger – Any token type, SOF, OUT, IN, SETUP; Address can be specified for Any Token, OUT, IN, and SETUP token types. Address can be further specified to trigger on ≤, <, =, >, ≥, ≠ a particular value, or inside or outside of a range. Frame number can be specified for SOF token using binary, hex, unsigned decimal and don't care digits. Data packet trigger – Any data type, DATA0, DATA1; Data can be further specified to trigger on ≤, <, =, >, ≥, ≠ a particular data value, or inside or outside of a range. Handshake packet trigger - Any handshake type, ACK, NAK, STALL. Special packet trigger – Any special type, PRE, Reserved. Error trigger - PID Check, CRC5 or CRC16, Bit Stuffing. High-speed: Trigger on Sync, Reset, Suspend, Resume, End of Packet, Token (Address) Packet, Data Packet, Handshake Packet, Special Packet, Error. Token packet trigger - Any token type, SOF, OUT, IN, SETUP; Address can be specified for Any Token, OUT, IN, and SETUP token types. Address can be further specified to trigger on ≤, <, =, >, ≥, ≠ a particular value, or inside or outside of a range. Frame number can be specified for SOF token using binary, hex, unsigned decimal and don't care digits. Data packet trigger – Any data type, DATA0, DATA1, DATA2, DATAM; Data can be further specified to trigger on ≤, <, =, >, ≥, ≠ a particular data value, or inside or outside of a range. Handshake packet trigger – Any handshake type, ACK, NAK, STALL, NYET. Special packet trigger – Any special type, ERR, SPLIT, PING, Reserved. SPLIT packet components that can be specified include: Hub Address Start/Complete - Don't Care, Start (SSPLIT), Complete (CSPLIT) Port Address Start and End bits - Don't Care, Control/Bulk/Interrupt (Full-speed Device, Low-speed Device), Isochronous (Data is Middle, Data is End, Data is Start, Data is All) Endpoint Type – Don't Care, Control, Isochronous, Bulk, Interrupt Error trigger - PID Check, CRC5 or CRC16, Any. High-speed support only available on MDO4104-3 and MDO4104-6 models 10BASE-T: Trigger on Start Frame Delimiter, MAC Addresses, MAC Q-Tag Control Information, MAC Length/Type, IP Header, TCP Header, Ethernet (Optional) TCP/IPv4/MAC Client Data, End of Packet, FCS (CRC) Error. MAC Addresses - Trigger on Source and Destination 48-bit address values. MAC Q-Tag Control Information – Trigger on Q-Tag 32-bit value. MAC Length/Type – Trigger on ≤, <, =, >, ≥, ≠ a particular 16-bit value, or inside or outside of a range. IP Header – Trigger on IP Protocol 8-bit value, Source Address, Destination Address. TCP Header – Trigger on Source Port, Destination Port, Sequence Number, and Ack Number. TCP/IPv4/MAC Client Data – Trigger on ≤, <, =, >, ≥, ≠ a particular data value, or inside or outside of a range. Selectable number of bytes to trigger on from 1-16. Byte offset options of Don't Care, 0-1499 100BASE-TX: Trigger on Start Frame Delimiter, MAC Addresses, MAC Q-Tag Control Information, MAC Length/Type, IP Header, TCP Header, TCP/IPv4/MAC Client Data, End of Packet, FCS (CRC) Error, Idle MAC Addresses - Trigger on Source and Destination 48-bit address values. MAC Q-Tag Control Information – Trigger on Q-Tag 32-bit value. MAC Length/Type – Trigger on \leq , <, =, >, \geq , \neq a particular 16-bit value, or inside or outside of a range. IP Header - Trigger on IP Protocol 8-bit value, Source Address, Destination Address. TCP Header - Trigger on Source Port, Destination Port, Sequence Number, and Ack Number. TCP/IPv4/MAC Client Data – Trigger on ≤, <, =, >, ≥, ≠ a particular data value, or inside or outside of a range. Selectable number of bytes to trigger on from 1-16. Byte offset options of Don't Care, 0-1499. CAN (Optional) Trigger on Start of Frame, Frame Type (data, remote, error, overload), Identifier (standard or extended), Data, Identifier and Data, End of Frame, Missing ACK, or Bit Stuffing Error on CAN signals up to 1 Mb/s. Data can be further specified to trigger on ≤, <, =, >, ≥, or ≠ a specific data value. User-adjustable sample point is set to 50% by default Trigger on Sync, Identifier, Data, Identifier and Data, Wakeup Frame, Sleep Frame, Errors such as Sync, Parity, or Checksum Errors up to 100 Kb/s LIN (Optional) (by LIN definition, 20 Kb/s) FlexRay (Optional) Trigger on Start of Frame, Type of Frame (Normal, Payload, Null, Sync, Startup), Identifier, Cycle Count, Complete Header Field, Data, Identifier and Data, End of Frame or Errors such as Header CRC, Trailer CRC, Null Frame, Sync Frame, or Startup Frame Errors up to 100 Mb/s RS-232/422/485/UART Trigger on Tx Start Bit, Rx Start Bit, Tx End of Packet, Rx End of Packet, Tx Data, Rx Data, Tx Parity Error, and Rx Parity Error up to 10 Mb/s (Optional)

Mode	Description
MIL-STD-1553 (Optional)	Trigger on Sync, Word Type*¹ (Command, Status, Data), Command Word*¹ (set RT Address, T/R, Sub-address/Mode, Data Word Count/Mode Code, and Parity individually), Status Word*¹ (set RT Address, Message Error, Instrumentation, Service Request Bit, Broadcast Command Received, Busy, Subsystem Flag, Dynamic Bus Control Acceptance (DBCA), Terminal Flag, and Parity individually), Data Word (user-specified 16-bit data value), Error (Sync, Parity, Manchester, Non-contiguous data), Idle Time (minimum time selectable from 4 µs to 100 µs; maximum time selectable from 12 µs to 100 µs; trigger on < minimum, > maximum, inside range, outside range). RT Address can be further specified to trigger on =, ≠, <, >, ≤, ≥ a particular value, or inside or outside of a range.
I ² S/LJ/RJ/TDM (Optional)	Trigger on Word Select, Frame Sync, or Data. Data can be further specified to trigger on ≤, <, =, >, ≥, ≠ a specific data value, or inside or outside of a range Maximum data rate for I ² S/LJ/RJ is 12.5 Mb/s Maximum data rate for TDM is 25 Mb/s
Parallel	Trigger on a parallel bus data value. Parallel bus can be from 1 to 20 bits in size. Binary and Hex radices are supported

^{*1} Trigger selection of Command Word will trigger on Command and ambiguous Command/Status words. Trigger selection of Status Word will trigger on Status and ambiguous Command/Status words.

Acquisition Modes

Mode	Description	
Sample	Acquire sampled values	
Peak Detect	Captures glitches as narrow as 800 ps (1 GHz models) or 1.6 ns (500 MHz models) at all sweep speeds	
Averaging	From 2 to 512 waveforms included in average	
Envelope	Min-Max envelope reflecting Peak Detect data over multiple acquisitions	
Hi Res	Real-time boxcar averaging reduces random noise and increases vertical resolution	
Roll	Scrolls waveforms right to left across the screen at sweep speeds slower than or equal to 40 ms/div	

Description	Waveform Measurements			
Automatic Measurements – Time Domain 29, of which up to eight can be displayed on-screen at any one time. Measurements include: Period, Frequency, Delay, Rise Time, Fall Time, Positive Duty Cycle, Negative Duty Cycle, Positive Pulse Width, Negative Pulse Width, Brase, Positive Pulse Width, Phase, Positive Overshoot, Negative Overshoot, Peak-to-Peak, Amplitude, High, Low, Max, Min, Mean, Cycle Mean, RMS, Cycle RMS, Positive Pulse Count, Negative Pulse Count, Rising Edge Count, Falling Edge Count, Area and Cycle Area Automatic Measurements – Frequency Domain Power, Adjacent Channel Power Ratio (ACPR), and Occupied Bandwidth (OBW) Measurement Statistics Reference Levels User-definable reference levels for automatic measurements can be specified in either percent or units Gating Isolate the specific occurrence within an acquisition to take measurements on, using either the screen or waveform cursors Waveform Histogram A waveform histogram provides an array of data values representing the total number of hits inside of a user-defined region of the display. A waveform histogram is both a visual graph of the hit distribution as well as a numeric array of values that can be measured. Sources – Channel 1, Channel 2, Channel 3, Channel 4, Ref 1, Ref 2, Ref 3, Ref 4, Math Types – Vertical, Horizontal Waveform Histogram Measurements Max, Min, Peak-to-Peak, Mean, Standard	Measurement	Description		
Measurements – Time Domain on-screen at any one time. Measurements include: Period, Frequency, Delay, Rise Time, Fall Time, Positive Duty Cycle, Negative Duty Cycle, Positive Pulse Width, Negative Pulse Width, Burst Width, Phase, Positive Overshoot, Negative Overshoot, Peak-to-Peak, Amplitude, High, Low, Max, Min, Mean, Cycle Mean, RMS, Cycle RMS, Positive Pulse Count, Negative Pulse Count, Rising Edge Count, Falling Edge Count, Area and Cycle Area Automatic Measurements – Frequency Domain Automatic Measurements – Frequency Domain Measurement Sundade Channel Power Ratio (ACPR), and Occupied Bandwidth (OBW) Mean, Min, Max, Standard Deviation Mean, Min, Max, Standard Deviation Mean, Min, Max, Standard Deviation Statistics Gating Isolate the specific occurrence within an acquisition to take measurements on, using either the screen or waveform cursors Waveform Histogram A waveform histogram provides an array of data values representing the total number of hits inside of a user-defined region of the display. A waveform histogram is both a visual graph of the hit distribution as well as a numeric array of values that can be measured. Sources – Channel 1, Channel 2, Channel 3, Channel 4, Ref 1, Ref 2, Ref 3, Ref 4, Math Types – Vertical, Horizontal Waveform Histogram Measurements Waveform Count, Hits in Box, Peak Hits, Median, Max, Min, Peak-to-Peak, Mean, Standard	Cursors	Waveform and Screen		
Measurements – Frequency Domain any one time. Measurements include Channel Power, Adjacent Channel Power Ratio (ACPR), and Occupied Bandwidth (OBW) Measurement Statistics Reference Levels User-definable reference levels for automatic measurements can be specified in either percent or units Gating Isolate the specific occurrence within an acquisition to take measurements on, using either the screen or waveform cursors Waveform Histogram A waveform histogram provides an array of data values representing the total number of hits inside of a user-defined region of the display. A waveform histogram is both a visual graph of the hit distribution as well as a numeric array of values that can be measured. Sources – Channel 1, Channel 2, Channel 3, Channel 4, Ref 1, Ref 2, Ref 3, Ref 4, Math Types – Vertical, Horizontal Waveform Histogram Waveform Count, Hits in Box, Peak Hits, Median, Max, Min, Peak-to-Peak, Mean, Standard	Measurements -	on-screen at any one time. Measurements include: Period, Frequency, Delay, Rise Time, Fall Time, Positive Duty Cycle, Negative Duty Cycle, Positive Pulse Width, Negative Pulse Width, Burst Width, Phase, Positive Overshoot, Negative Overshoot, Peak-to-Peak, Amplitude, High, Low, Max, Min, Mean, Cycle Mean, RMS, Cycle RMS, Positive Pulse Count, Negative Pulse Count, Rising Edge		
Statistics Reference Levels User-definable reference levels for automatic measurements can be specified in either percent or units Gating Isolate the specific occurrence within an acquisition to take measurements on, using either the screen or waveform cursors Waveform Histogram A waveform histogram provides an array of data values representing the total number of hits inside of a user-defined region of the display. A waveform histogram is both a visual graph of the hit distribution as well as a numeric array of values that can be measured. Sources – Channel 1, Channel 2, Channel 3, Channel 4, Ref 1, Ref 2, Ref 3, Ref 4, Math Types – Vertical, Horizontal Waveform Histogram Waveform Count, Hits in Box, Peak Hits, Median, Max, Min, Peak-to-Peak, Mean, Standard	Measurements - 500	any one time. Measurements include Channel Power, Adjacent Channel Power Ratio (ACPR),		
measurements can be specified in either percent or units Isolate the specific occurrence within an acquisition to take measurements on, using either the screen or waveform cursors Waveform Histogram A waveform histogram provides an array of data values representing the total number of hits inside of a user-defined region of the display. A waveform histogram is both a visual graph of the hit distribution as well as a numeric array of values that can be measured. Sources – Channel 1, Channel 2, Channel 3, Channel 4, Ref 1, Ref 2, Ref 3, Ref 4, Math Types – Vertical, Horizontal Waveform Histogram Waveform Count, Hits in Box, Peak Hits, Median, Max, Min, Peak-to-Peak, Mean, Standard		Mean, Min, Max, Standard Deviation		
to take measurements on, using either the screen or waveform cursors Waveform Histogram A waveform histogram provides an array of data values representing the total number of hits inside of a user-defined region of the display. A waveform histogram is both a visual graph of the hit distribution as well as a numeric array of values that can be measured. Sources – Channel 1, Channel 2, Channel 3, Channel 4, Ref 1, Ref 2, Ref 3, Ref 4, Math Types – Vertical, Horizontal Waveform Histogram Waveform Count, Hits in Box, Peak Hits, Median, Max, Min, Peak-to-Peak, Mean, Standard	Reference Levels	measurements can be specified in either percent		
values representing the total number of hits inside of a user-defined region of the display. A waveform histogram is both a visual graph of the hit distribution as well as a numeric array of values that can be measured. Sources – Channel 1, Channel 2, Channel 3, Channel 4, Ref 1, Ref 2, Ref 3, Ref 4, Math Types – Vertical, Horizontal Waveform Histogram Waveform Count, Hits in Box, Peak Hits, Median, Max, Min, Peak-to-Peak, Mean, Standard	Gating	to take measurements on, using either the screen		
Measurements Max, Min, Peak-to-Peak, Mean, Standard	Waveform Histogram	values representing the total number of hits inside of a user-defined region of the display. A waveform histogram is both a visual graph of the hit distribution as well as a numeric array of values that can be measured. Sources – Channel 1, Channel 2, Channel 3, Channel 4, Ref 1, Ref 2, Ref 3, Ref 4, Math		
		Max, Min, Peak-to-Peak, Mean, Standard		

Waveform Math

Characteristic	Description	
Arithmetic	Add, subtract, multiply, and divide waveforms	
Math Functions	Integrate, Differentiate, FFT	
FFT	Spectral magnitude	
	FFT Vertical Scale: Linear RMS or dBV RMS	
	FFT Window Settings: Rectangular, Hamming, Hanning, Blackman Harris	
Spectrum Math	Add or subtract frequency domain traces	
Advanced Math	Define extensive algebraic expressions including waveforms, reference waveforms, math functions. Perform math on math using complex equations (FFT, Intg, Diff, Log, Exp, Sqrt, Abs, Sine, Cosine, Tangent, Rad, Deg), scalars, up to two user-adjustable variables and results of parametric measurements (Period, Freq, Delay, Rise, Fall, PosWidth, NegWidth, BurstWidth, Phase, PosDutyCycle, NegDutyCycle, PosOverShoot, NegOverShoot, PeakPeak, Amplitude, RMS, CycleRMS, High, Low, Max, Min, Mean, CycleMean, Area, CycleArea, and trend plots) e.g. (Intg(Ch1-Mean(Ch1))×1.414×VAR1)	

Power Measurements (Optional)

	` ' '	
Measurement	Description	
Power Quality Measurements	V _{RMS} , V _{Crest Factor} , Frequency, I _{RMS} , I _{Crest Factor} , True Power, Apparent Power, Reactive Power, Power Factor, Phase Angle	
Switching Loss	Power Loss: T _{on} , T _{off} , Conduction, Total	
Measurements	Energy Loss: Ton, Toff, Conduction, Total	
Harmonics	THD-F, THD-R, RMS measurements	
	Graphical and table displays of harmonics	
	Test to IEC61000-3-2 Class A and MIL-STD-1399 Section 300A	
Ripple Measurements	V _{ripple} and I _{ripple}	
Modulation Analysis	Graphical display of +Pulse Width, -Pulse Width, Period, Frequency, +Duty Cycle, and -Duty Cycle modulation types	
Safe Operating Area	Graphical display and mask testing of switching device safe operating area measurements	
dV/dt and dI/dt Measurements	Cursor measurements of slew rate	

Limit/Mask Testing (Optional)

Description

Characteristic

Included Standard Masks	ITU-T, ANSI T1.102, USB
Test Source	Limit Test: Any Ch1 - Ch4 or any R1 - R4
lest Source	Mask Test: Any Ch1 - Ch4
Mask Creation	Limit test vertical tolerance from 0 to 1 division in 1 m
	division increments; Limit test horizontal tolerance from 0 to 500 m division in 1 m division increments
	Load standard mask from internal memory
	Load custom mask from text file with up to 8 segments
Mook Cooling	
Mask Scaling	Lock to Source ON (mask automatically re-scales with source-channel settings changes)
	Lock to Source OFF (mask does not re-scale with
	source-channel settings changes)
Test Criteria Run Until	Minimum number of waveforms (from 1 to 1,000,000;
	Infinity) Minimum clansed time (from 1 cocond to 48 hours:
	Minimum elapsed time (from 1 second to 48 hours; Infinity)
Violation Threshold	From 1 to 1,000,000
Actions on Test Failure	Stop acquisition, save screen image to file, save
	waveform to file, print screen image, trigger out pulse,
	set remote interface SRQ
Actions on Test Complete	Trigger out pulse, set remote interface SRQ
Results Display	Test status, total waveforms, number of violations,
	violation rate, total tests, failed tests, test failure rate, elapsed time, total hits for each mask segment
	elapsed line, total filts for each mask segment
Software Software	anthe
Software	Description
NI LabVIEW	A fully interactive measurement software environment
SignalExpress Tektronix	optimized for the MDO4000 Series, enables you to
Edition	instantly acquire, generate, analyze, compare, import, and save measurement data and signals using an
Signal Express Tektronix Edition	intuitive drag-and-drop user interface that does not
St N.	require any programming.
COL	Standard MDO4000 Series support for acquiring, controlling, viewing, and exporting your live signal data
Ö.	is permanently available through the software. The full
	version (SIGEXPTE) adds additional signal processing,
	advanced analysis, mixed signal, sweeping, limit
	testing, and user-defined step capabilities and is available for a 30-day trial period standard with each
	instrument.
OpenChoice® Desktop	Enables fast and easy communication between a
·	Windows PC and the MDO4000 Series, using USB
	or LAN. Transfer and save settings, waveforms,
	measurements, and screen images. Included Word and Excel toolbars automate the transfer of acquisition
	data and screen images from the oscilloscope into
	Word and Excel for quick reporting or further analysis.
IVI Driver	Provides a standard instrument programming
	interface for common applications such as LabVIEW,
e*Scone® Web-based	interface for common applications such as LabVIEW, LabWindows/CVI, Microsoft .NET and MATLAB.
e*Scope® Web-based Remote Control	interface for common applications such as LabVIEW, LabWindows/CVI, Microsoft .NET and MATLAB. Enables control of the MDO4000 Series over a
	interface for common applications such as LabVIEW, LabWindows/CVI, Microsoft .NET and MATLAB. Enables control of the MDO4000 Series over a network connection through a standard web browser. Simply enter the IP address or network name of the
	interface for common applications such as LabVIEW, LabWindows/CVI, Microsoft .NET and MATLAB. Enables control of the MDO4000 Series over a network connection through a standard web browser. Simply enter the IP address or network name of the oscilloscope and a web page will be served to the
Remote Control	interface for common applications such as LabVIEW, LabWindows/CVI, Microsoft .NET and MATLAB. Enables control of the MDO4000 Series over a network connection through a standard web browser. Simply enter the IP address or network name of the oscilloscope and a web page will be served to the browser.
Remote Control LXI Class C	interface for common applications such as LabVIEW, LabWindows/CVI, Microsoft .NET and MATLAB. Enables control of the MDO4000 Series over a network connection through a standard web browser. Simply enter the IP address or network name of the oscilloscope and a web page will be served to the browser. Connect to the MDO4000 Series through a standard
Remote Control	interface for common applications such as LabVIEW, LabWindows/CVI, Microsoft .NET and MATLAB. Enables control of the MDO4000 Series over a network connection through a standard web browser. Simply enter the IP address or network name of the oscilloscope and a web page will be served to the browser.
Remote Control LXI Class C	interface for common applications such as LabVIEW, LabWindows/CVI, Microsoft .NET and MATLAB. Enables control of the MDO4000 Series over a network connection through a standard web browser. Simply enter the IP address or network name of the oscilloscope and a web page will be served to the browser. Connect to the MDO4000 Series through a standard web browser by simply entering the oscilloscope's
Remote Control LXI Class C	interface for common applications such as LabVIEW, LabWindows/CVI, Microsoft .NET and MATLAB. Enables control of the MDO4000 Series over a network connection through a standard web browser. Simply enter the IP address or network name of the oscilloscope and a web page will be served to the browser. Connect to the MDO4000 Series through a standard web browser by simply entering the oscilloscope's IP address or network name in the address bar of the browser. The web interface enables viewing of instrument status and configuration, status and
Remote Control LXI Class C	interface for common applications such as LabVIEW, LabWindows/CVI, Microsoft .NET and MATLAB. Enables control of the MDO4000 Series over a network connection through a standard web browser. Simply enter the IP address or network name of the oscilloscope and a web page will be served to the browser. Connect to the MDO4000 Series through a standard web browser by simply entering the oscilloscope's IP address or network name in the address bar of the browser. The web interface enables viewing of instrument status and configuration, status and modification of network settings, and instrument control
Remote Control LXI Class C	interface for common applications such as LabVIEW, LabWindows/CVI, Microsoft .NET and MATLAB. Enables control of the MDO4000 Series over a network connection through a standard web browser. Simply enter the IP address or network name of the oscilloscope and a web page will be served to the browser. Connect to the MDO4000 Series through a standard web browser by simply entering the oscilloscope's IP address or network name in the address bar of the browser. The web interface enables viewing of instrument status and configuration, status and

Display Characteristics

Characteristic	Description	
Display Type	10.4 in. (264 mm) liquid-crystal TFT color display	
Display Resolution	1,024 horizontal × 768 vertical pixels (XGA)	
Waveform Styles	Vectors, Dots, Variable Persistence, Infinite Persistence	
Graticules	Full, Grid, Solid, Cross Hair, Frame, IRE, and mV	
Format	YT and simultaneous XY/YT	
Waveform Capture Rate	>50,000 wfm/s maximum	

Input/Output Ports

Port	Description	
USB 2.0 High-speed Host Port	Supports USB mass storage devices, printers and keyboard. Two ports on front and two ports on rear of instrument	
USB 2.0 Device Port	Rear-panel connector allows for communication/control of oscilloscope through USBTMC or GPIB (with a TEK-USB-488), and direct printing to all PictBridge-compatible printers	
LAN Port	RJ-45 connector, supports 10/100/1000 Mb/s	
XGA Video Port	DB-15 female connector, connect to show the oscilloscope display on an external monitor or projector	
Probe Compensator Output	Front-panel pins Amplitude: 2.5 V Frequency: 1 kHz	
Auxiliary Out	Rear-panel BNC connector V_{OUT} (Hi): \geq 2.5 V open circuit, \geq 1.0 V 50 Ω to ground V_{OUT} (Lo): \leq 0.7 V into a load of \leq 4 mA; \leq 0.25 V 50 Ω to ground	
	Output can be configured to provide a pulse out signal when the oscilloscope triggers, the internal oscilloscope reference clock out, or an event out for limit/mask testing	
External Reference In	Time-base system can phase lock to an external 10 MHz reference (10 MHz ±1%)	
Kensington Lock	Rear-panel security slot connects to standard Kensington lock	
VESA Mount	Mount Standard (MIS-D 100) 100 mm VESA mounting poil on rear of instrument	

LAN eXtensions for Instrumentation (LXI)

Characteristic	Description	On co
Class	LXI Class C	III.
Version	V1.3	

Power Source

Characteristic	Description
Power Source Voltage	100 to 240 V ±10%
Power Source Frequency	45 to 66 Hz (85 to 264 V) 360 to 440 Hz (100 to 132 V)
Power Consumption	225 W maximum

Physical Characteristics

Dimensions	mm	in.	
Height	229	9.0	
Width	439	17.3	
Depth	147	5.8	
Weight	kg	lb.	
Net	5	11	
Shipping	10.7	23.6	
Rackmount Configuration	5U		
Cooling Clearance	2 in. (51 mm) required on left side and rear of instrument		

Environmental

Characteristic	Description
Temperature	
Operating	0 °C to +50 °C
Nonoperating	−20 °C to +60 °C
Humidity	
Operating	High: 40 °C to 50 °C, 10% to 60% Relative Humidity Low: 0 °C to 40 °C, 10% to 90% Relative Humidity
Nonoperating	High: 40 °C to 60 °C, 5% to 60% Relative Humidity Low: 0 °C to 40 °C, 5% to 90% Relative Humidity
Altitude	agin am
Operating	9,843 ft. (3,000 m)
Nonoperating	30,000 ft. (9,144 m)
Regulatory	u _o ,
Electromagnetic Compatibility	EC Council Directive 2004/108/EC
Safety	UL61010-1, Second Edition; CSA61010-1 Second Edition, EN61010-1:2001; IEC 61010-1:2001
Children.	Edition, EN61010-1:2001; IEC 61010-1:2001

Ordering Information

MDO4000 Family

Model	Description
MDO4054-3	Mixed Domain Oscilloscope with (4) 500 MHz analog channels, (16) digital channels, and (1) 3 GHz RF input
MDO4054-6	Mixed Domain Oscilloscope with (4) 500 MHz analog channels, (16) digital channels, and (1) 6 GHz RF input
MDO4104-3	Mixed Domain Oscilloscope with (4) 1 GHz analog channels, (16) digital channels, and (1) 3 GHz RF input
MDO4104-6	Mixed Domain Oscilloscope with (4) 1 GHz analog channels, (16) digital channels, and (1) 6 GHz RF input

All Models Include: One passive voltage probe per analog channel (TPP0500 500 MHz, 10X, 3.9 pF for 500 MHz models; TPP1000 1 GHz, 10X, 3.9 pF for 1 GHz models), P6616 16-channel Logic Probe, Logic Probe Accessory Kit (020-2662-xx), Front Cover (200-5130-xx), N-to-BNC Adapter (103-0045-00), User Manual (071-2918-xx), Documentation CD (063-4367-xx), OpenChoice® Desktop Software, NI LabVIEW SignalExpress™ Tektronix Edition Software, Calibration Certificates document measurement traceability to National Metrology Institute(s) – the Quality System this product is manufactured in is ISO9001 registered, power cord, accessory bag (016-2031-xx) and a three-year warranty. Please specify power cord, accessory bag (016-2030-xx) and a three-year warranty. Please specify power plug and manual language version when ordering.

Application Modules

Application modules have licenses which can be transferred between an application module and an oscilloscope. The license may be contained in the module; allowing the module to be moved from one instrument to another. Or, the license can be contained in the oscilloscope; allowing the module to be removed and stored for safekeeping. Transferring the license to an oscilloscope and removing the module permits the use of more than 4 applications simultaneously.

Module	re than 4 applications simultaneously. Description
DPO4AERO	Aerospace Serial Triggering and Analysis Module. Enables triggering on packet-level information on MIL-STD-1553 buses as well as analytical tools such as digital views of the signal, bus views, packet decoding, search tools, and packet decode tables with time-stamp information. Signal Inputs – Any Ch1 - Ch4, Math, Ref1 - Ref4 Recommended Probing – Differential or single ended (only one single-ended signal required)
DPO4AUDIO	Audio Serial Triggering and Analysis Module. Enables triggering on packet-level information on I ² S, LJ, RJ, and TDM audio buses as well as analytical tools such as digital views of the signal, bus views, packet decoding, search tools, and packet decode tables with time-stamp information. Signal Inputs – Any Ch1 - Ch4, D0 - D15 Recommended Probing – I ² S, LJ, RJ, TDM: Single ended
DPO4AUTO	Automotive Serial Triggering and Analysis Module. Enables triggering on packet-level information on CAN and LIN buses as well as analytical tools such as digital views of the signal, bus views, packet decoding, search tools, and packet decode tables with time-stamp information. Signal Inputs – LIN: Any Ch1 - Ch4, D0 - D15; CAN: Any Ch1 - Ch4, (D0 - D15; single-ended probing only) Recommended Probing – LIN: Single ended; CAN: Single ended or differential
DPO4AUTOMAX	Extended Automotive Serial Triggering and Analysis Module. Enables triggering on packet-level information on CAN, LIN, and FlexRay buses as well as analytical tools such as digital views of the signal, bus views, packet decoding, search tools, packet decode tables with time-stamp information, and eye diagram analysis software. Signal Inputs – LIN: Any Ch1 - Ch4, D0 - D15; CAN: Any Ch1 - Ch4, (D0 - D15; single-ended probing only); FlexRay: Any Ch1 - Ch4, (D0 - D15; single-ended probing only) Recommended Probing – LIN: Single ended; CAN, FlexRay: Single ended or differential
DPO4COMP	Computer Serial Triggering and Analysis Module. Enables triggering on packet-level information on RS-232/422/485/UART buses as well as analytical tools such as digital views of the signal, bus views, packet decoding, search tools, and packet decode tables with time-stamp information. Signal Inputs – Any Ch1 - Ch4, (D0 - D15; single-ending probing only) Recommended Probing – RS-232/UART: Single ended; RS-422/485: Differential

Module	Description	
DPO4EMBD	Embedded Serial Triggering and Analysis Module. Enables triggering on packet-level information on I ² C and SPI buses as well as analytical tools such as digital views of the signal, bus views, packet decoding, search tools, and packet decode tables with time-stamp information. Signal Inputs – I ² C: Any Ch1 - Ch4, D0 - D15; SPI: Any Ch1 - Ch4, D0 - D15 Recommended Probing – I ² C, SPI: Single ended	
DPO4ENET	Ethernet Serial Triggering and Analysis Module. Enables triggering on packet-level information on 10BASE-T and 100BASE-TX buses as well as analytical tools such as digital views of the signal, bus views, packet decoding, search tools, and packet decode tables with time-stamp information. Signal Inputs – Any Ch1 - Ch4 for single-ended probing; Any Ch1 - Ch4, Math, Ref1 - Ref4 for differential probing Recommended Probing – 10BASE-T: Single ended or differential; 100BASE-TX: Differential	
DPO4USB	USB Serial Triggering and Analysis Module. Enables triggering on packet-level content for low-speed, full-speed, and high-speed USB serial buses. Also enables analytical tools such as digital views of the signal, bus views, packet decoding, search tools, and packet decode tables with time-stamp information for low-speed, full-speed, and high-speed USB serial buses. Signal Inputs – Low-speed and Full-speed: Any Ch1 - Ch4, (D0 - D15; for single-ending probing only); Low-speed, Full-speed, and High-speed: Any Ch1 - Ch4, Math, Ref1 - Ref4 Recommended Probing – Low-speed and Full-speed: Single ended or differential; High-speed: Differential USB high-speed supported only on MDO4104-X models	
DPO4PWR	Power Analysis Application Module. Enables quick and accurate analysis of power quality, switching loss, harmonics, safe operating area (SOA), modulation, ripple, and slew rate (dl/dt, dV/dt)	
DPO4LMT	Limit and Mask Testing Application Module. Enables testing against limit templates generated from "golden" waveforms and mask testing using custom or standard telecommunications or computer masks	
DPO4VID	HDTV and Custom (nonstandard) Video Triggering Module	
MDO4TRIG	Advanced RF Power Level Triggering Module. Enables the power level on the RF input to be used as a source in the following trigger types: Pulse Width, Runt, Timeout, Logic, and Sequence	

Instrument Options

Power Plug Options

Option	Description
Opt. A0	North America
Opt. A1	Universal Euro
Opt. A2	United Kingdom
Opt. A3	Australia
Opt. A5	Switzerland
Opt. A6	Japan
Opt. A10	China
Opt. A11	India
Opt. A12	Brazil
Opt. A99	No power cord or AC adapter

Language Options*2

Opt. L0 English manual Opt. L1 French manual Opt. L2 Italian manual Opt. L3 German manual Opt. L4 Spanish manual Opt. L5 Japanese manual Opt. L6 Portuguese manual	Description	
Opt. L2 Italian manual Opt. L3 German manual Opt. L4 Spanish manual Opt. L5 Japanese manual Opt. L6 Portuguese manual	English manual	
Opt. L3 German manual Opt. L4 Spanish manual Opt. L5 Japanese manual Opt. L6 Portuguese manual	French manual	
Opt. L4 Spanish manual Opt. L5 Japanese manual Opt. L6 Portuguese manual	Italian manual	
Opt. L5 Japanese manual Opt. L6 Portuguese manual	German manual	
Opt. L6 Portuguese manual	Spanish manual	
	Japanese manual	
0	Portuguese manual	
Opt. L7 Simplified Chinese manual	Simplified Chinese manual	
Opt. L8 Traditional Chinese manual	Traditional Chinese manual	
Opt. L9 Korean manual	Korean manual	
Opt. L10 Russian manual	Russian manual	
Opt. L99 No manual	No manual	

^{*2} Language options include a translated front-panel overlay for the selected language(s).

Service Options*3

Option	Description	
Opt. C3	Calibration Service 3 years	
Opt. C5	Calibration Service 5 years	
Opt. D1	Calibration Data Report	
Opt. D3	Calibration Data Report 3 years (with Opt. C3)	
Opt. D5	Calibration Data Report 5 Years (with Opt. C5)	
Opt. G3	Complete Care 3 Years (includes loaner, scheduled calibration and more)	
Opt. G5	Complete Care 5 Years (includes loaner, scheduled calibration and more)	
Opt. R5	Repair Service 5 years (including warranty)	

^{*3} Probes and accessories are not covered by the oscilloscope warranty and service offerings. Refer to the datasheet of each probe and accessory model for its unique warranty and calibration terms.

Recommended Probes

Tektronix offers over 100 different probes to meet your application needs. For a comprehensive listing of available probes, please visit www.tektronix.com/probes.

Probe	Description	
TPP0500	500 MHz, 10X TekVPI® passive voltage probe with 3.9 pF input capacitance	
TPP0502	500 MHz, 2X TekVPI passive voltage probe with 3.9 pF input capacitance	
TPP0850	2.5 kV, 800 MHz, 50X TekVPI passive high-voltage probe	
TPP1000	1 GHz, 10X TekVPI passive voltage probe with 3.9 pF input capacitance	
TAP1500	1.5 GHz TekVPI active single-ended voltage probe	
TAP2500	2.5 GHz TekVPI active single-ended voltage probe	
TAP3500	3.5 GHz TekVPI active single-ended voltage probe	
TDP0500	500 MHz TekVPI differential voltage probe with ±42 V differential input voltage	
TDP1000	1 GHz TekVPI differential voltage probe with ±42 V differential input voltage	
TDP1500	1.5 GHz TekVPI differential voltage probe with ±8.5 V differential input voltage	
TDP3500	3.5 GHz TekVPI differential voltage probe with ±2 V differential input voltage	
TCP0030	120 MHz TekVPI 30 Ampere AC/DC current probe	
TCP0150	20 MHz TekVPI 150 Ampere AC/DC current probe	
P5200A	1.3 kV, 50 MHz high-voltage differential probe	
P5202A*4	640 V, 100 MHz high-voltage differential probe	
P5205A*4	1.3 kV, 200 MHz high-voltage differential probe	
P5210A*4	5.6 kV, 50 MHz high-voltage differential probe	
P5100A	2.5 kV, 100X high-voltage passive probe	
*4 Requires TekV/PI® to TekProhe BNC adapter (TPA-BNC)		

^{*4} Requires TekVPI® to TekProbe BNC adapter (TPA-BNC).

	P5100A	2.5 kV, 100X high-voltage passive probe
	*4 Requires TekVPI® to TekPro	be BNC adapter (TPA-BNC).
	They may	
	Recommended A	ccessories
0	Accessory	Description
conduser	119-4146-00	Near Field Probe Set, 100 kHz - 1 GHz
Olo Me	119-6609-00	Flexible Monopole Antenna
Co dillo.	TPA-N-VPI	N-to-TekVPI Adapter
K.C.	077-0585-xx	Service Manual (English only)
3	SIGEXPTE	NI LabVIEW SignalExpress™ Tektronix Edition Software (Full Version)
	FPGAView-xx	MSO Support for Altera and Xilinx FPGAs
	TPA-BNC	TekVPI-to-TekProbe BNC Adapter
duled	TEK-USB-488	GPIB-to-USB Adapter
	ACD4000B	Soft Transit Case
duled	HCTEK54	Hard Transit Case (Requires ACD4000B)
	RMD5000	Rackmount Kit
fer to the	TEK-DPG	Deskew Pulse Generator
ICI IO IIIC	067-1686-xx	Deskew Fixture

Warranty

Three-year warranty covering all parts and labor, excluding probes.





Product(s) are manufactured in ISO registered facilities.



Product(s) complies with IEEE Standard 488.1-1987, RS-232-C, and with Tektronix Standard Codes and Formats.

ASEAN / Australasia (65) 6356 3900

Austria 00800 2255 4835*

Balkans, Israel, South Africa and other ISE Countries +41 52 675 3777

Belgium 00800 2255 4835*

Brazil +55 (11) 3759 7627

Canada 1 800 833 9200 Central East Europe and the Baltics +41 52 675 3777

Central Europe & Greece +41 52 675 3777

Denmark +45 80 88 1401

Finland +41 52 675 3777

France 00800 2255 4835*

Germany 00800 2255 4835*

Hong Kong 400 820 5835

India 000 800 650 1835

Italy 00800 2255 4835* Japan 81 (3) 6714 3010

Luxembourg +41 52 675 3777

Mexico, Central/South America & Caribbean 52 (55) 56 04 50 90

Middle East, Asia, and North Africa +41 52 675 3777

The Netherlands 00800 2255 4835*

Norway 800 16098

People's Republic of China 400 820 5835

Poland +41 52 675 3777

Portugal 80 08 12370 Republic of Korea 001 800 8255 2835

Russia & CIS +7 (495) 7484900

South Africa +41 52 675 3777

Spain 00800 2255 4835*

Sweden 00800 2255 4835* Switzerland 00800 2255 4835*

Taiwan 886 (2) 2722 9622

United Kingdom & Ireland 00800 2255 4835*

USA 1 800 833 9200

* European toll-free number. If not accessible, call: +41 52 675 3777

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